# **Power MOSFET** 40 V, 6.9 mΩ, 44 A, Dual N–Channel Logic Level, Dual SO–8FL

### Features

- Small Footprint (5x6 mm) for Compact Designs
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- NVMFD5852NLWF Wettable Flanks Product
- AEC-Q101 Qualified and PPAP Capable
- This is a Pb–Free Device

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

			,			
Parameter			Symbol	Value	Unit	
Drain-to-Source Voltage			V <sub>DSS</sub>	40	V	
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V	
Continuous Drain Current $R_{\Psi J-mb}$ (Notes 1,		T <sub>mb</sub> = 25°C	۱ <sub>D</sub>	44	A	
2, 3, 4)	Steady	T <sub>mb</sub> = 100°C		31		
Power Dissipation	State	T <sub>mb</sub> = 25°C	PD	27	W	
R <sub>ΨJ-mb</sub> (Notes 1, 2, 3)		T <sub>mb</sub> = 100°C		13		
Continuous Drain Current $R_{\theta,IA}$ (Notes 1, 3	Steady State	T <sub>A</sub> = 25°C	۱ <sub>D</sub>	15	A	
& 4)		T <sub>A</sub> = 100°C		10.6		
Power Dissipation		T <sub>A</sub> = 25°C	PD	3.2	W	
$R_{\theta JA}$ (Notes 1 & 3)		T <sub>A</sub> = 100°C		1.6		
Pulsed Drain Current	T <sub>A</sub> = 25	°C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	329	Α	
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	-55 to 175	°C	
Source Current (Body Diode)			ا <sub>S</sub>	40	Α	
$ \begin{array}{l} \mbox{Single Pulse Drain-to-S} \\ \mbox{Energy} \ (T_J = 25^\circ C, \ V_{GS} \\ \mbox{L} = 0.1 \ mH, \ R_G = 25 \ \Omega ) \end{array} $			E <sub>AS</sub>	80	mJ	
Lead Temperature for S (1/8" from case for 10 s)		Purposes	TL	260	°C	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

#### THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Mounting Board (top) - Steady State (Notes 2, 3)	$R_{\Psi J-mb}$	5.6	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\thetaJA}$	47	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Psi ( $\Psi$ ) is used as required per JESD51–12 for packages in which substantially less than 100% of the heat flows to single case surface.

3. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.

4. Maximum current for pulses as long as 1 second are higher but are dependent on pulse duration and duty cycle.

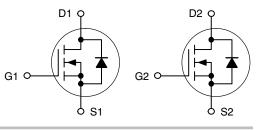


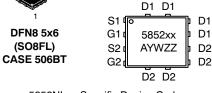
# **ON Semiconductor®**

### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
40 V	$6.9~\mathrm{m}\Omega @~10~\mathrm{V}$	44 A
40 V	12.0 mΩ @ 4.5 V	77 A

Dual N-Channel





5852NL	= Specific Device Code
	for NVMFD5852NL
5852LW	= Specific Device Code
	for NVMFD5852NLWF
Α	= Assembly Location
Y	= Year
W	= Work Week

ZZ = Lot Traceability

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NVMFD5852NLT1G	DFN8 (Pb-Free)	1500 / Tape & Reel
NVMFD5852NLWFT1G	DFN8 (Pb-Free)	1500 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Cond	ition	Min	Тур	Max	Unit
OFF CHARACTERISTICS						-	
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				37.3		mV/°C
Zero Gate Voltage Drain Current	IDSS	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 40 V	T <sub>J</sub> = 25°C T <sub>.1</sub> = 125°C			1.0 100	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub>	ů			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> =	= 250 μA	1.4		2.4	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				6.3		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>E</sub>	) = 20 A		5.3	6.9	mΩ
		V <sub>GS</sub> = 4.5 V, I <sub>I</sub>	<sub>0</sub> = 20 A		8.7	12	1
Forward Transconductance	<b>9</b> FS	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 5 A			24		S
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = 25 V			1800		pF
Output Capacitance	C <sub>oss</sub>				240		
Reverse Transfer Capacitance	C <sub>rss</sub>				180		
Total Gate Charge	Q <sub>G(TOT)</sub>				20		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>D</sub>	<sub>S</sub> = 32 V,		1.5		
Gate-to-Source Charge	Q <sub>GS</sub>	I <sub>D</sub> = 20	Ā		5.5		
Gate-to-Drain Charge	Q <sub>GD</sub>				10.9		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = 10 \text{ V}, \text{ V}_{DS} = 32 \text{ V}, \text{ I}_{D} = 20 \text{ A}$			36		nC
SWITCHING CHARACTERISTICS (No	ote 6)						
Turn-On Delay Time	t <sub>d(on)</sub>				12		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V <sub>D</sub>	<sub>S</sub> = 32 V,		52		
Turn-Off Delay Time	t <sub>d(off)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>D</sub> I <sub>D</sub> = 20 A, R <sub>G</sub>	= 2.5 Ω		21		1
Fall Time	t <sub>f</sub>				13		
Turn-On Delay Time	t <sub>d(on)</sub>				12		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V <sub>D</sub>	<sub>3</sub> = 32 V,		8.0		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D = 20 \text{ A}, \text{ R}_G = 2.5 \Omega$			27		
Fall Time	t <sub>f</sub>				5.0		
DRAIN-SOURCE DIODE CHARACTE	ERISTICS						-
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 20 A	T <sub>J</sub> = 25°C T <sub>J</sub> = 125°C		0.84	1.1	V
Reverse Recovery Time	t <sub>RR</sub>		1.5 .200		22.3		ns
Charge Time	t <sub>a</sub>	$\label{eq:VGS} \begin{array}{l} V_{GS} = 0 \ V, \ d_{IS}/d_t = 100 \ \text{A}/\mu\text{s}, \\ I_S = 20 \ \text{A} \end{array}$			12.8		-
Discharge Time	t <sub>b</sub>				9.4		-
					+		

Reverse Recovery Charge

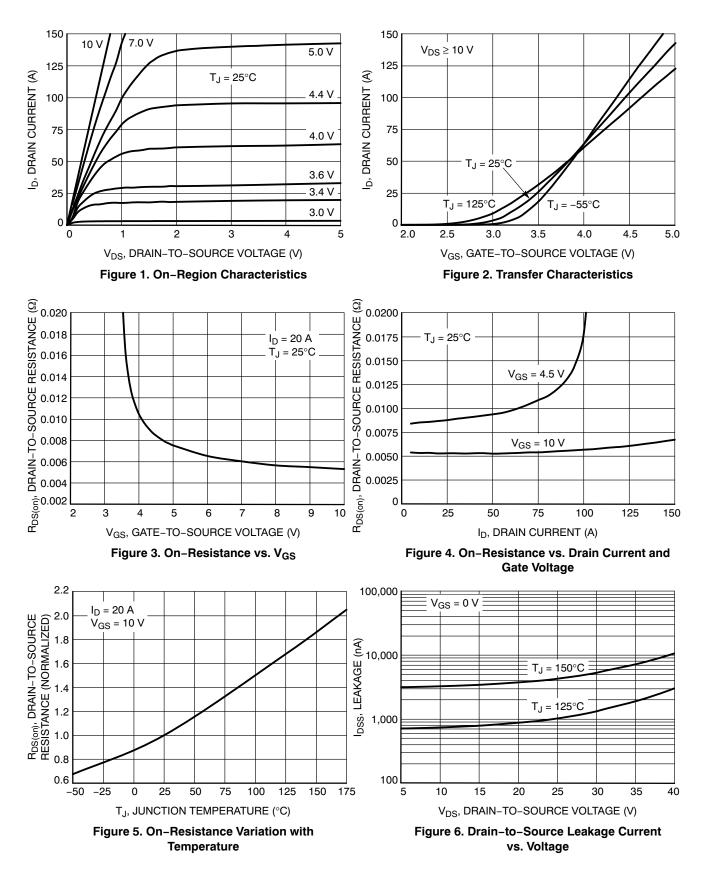
5. Pulse Test: pulse width = 300 μs, duty cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

Q<sub>RR</sub>

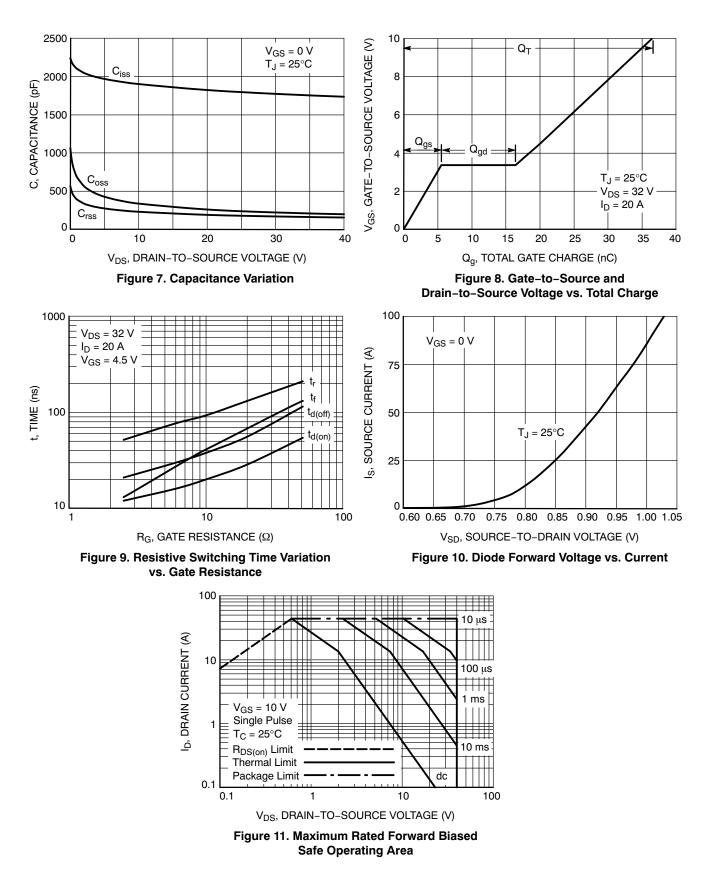
15.2

nC

# **TYPICAL CHARACTERISTICS**



## **TYPICAL CHARACTERISTICS**



**TYPICAL CHARACTERISTICS** 

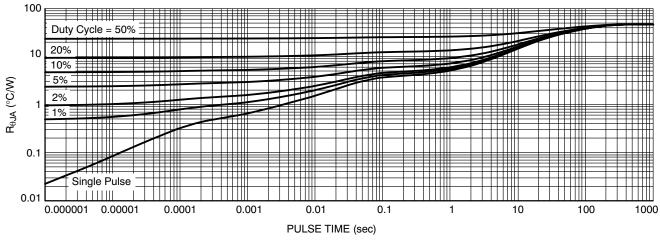
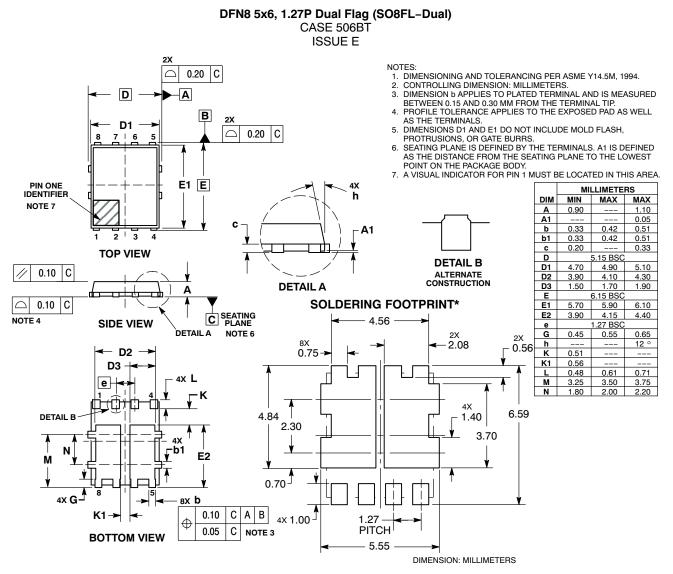


Figure 12. Thermal Response

#### PACKAGE DIMENSIONS



\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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